# MSKSEMI 美森科













ESD

TSS

MOV

GDT

PIFD

DTA114EE(MS)

**Product specification** 





# Digital Transistor (Built-in Resistors) PNP Silicon Surface Mount Transistor

#### **FEATURES**

- Built-in resistors enable the configuration of a inverter circuit without connecting external input resistors.
- The bias resistors consist of thin-film resistors with complete isolation to allow positive biasing of the input. They also have the advantage of almost completely eliminating parasitic effects.
- Only the on/off conditions need to be set for operation, making device design easy.
- RoHS Compliant
- Green EMC
- Matte Tin(Sn) Lead Finish
- Weight: approx. 0.002g

## **Absolute Maximum Ratings** (TA = 25°C unless otherwise noted)

Symbol	Parameter	Value	Units
Vcc	Supply Voltage	-50	V
Vin	Input Voltage	-40 ~ +10	V
lo	Output Current	-50	mA
I <sub>CM</sub>	Peak Collector Current	-100	mA
P <sub>D</sub>	Power Dissipation	150	mW
TJ	Junction to Ambient	150	°C
T <sub>STG</sub>	Storage Temperature Range	-55 to +150	℃

These ratings are limiting values above which the serviceability of the device may be impaired

#### **Reference News**

Pin Configuration	ELECTRICAL SYMBOL	Marking	
1.IN 2.GND 3.OUT	IN O GND(+)  IN O GND(+)	14	
SOT-523			

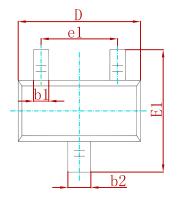


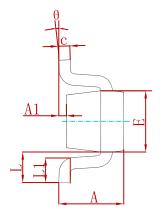
# **Electrical Characteristics** (T<sub>A</sub> = 25° C unless otherwise noted)

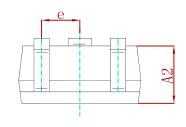
Doromotor	Symbol Test Condition	Limits			Unit	
Parameter		rest Condition	Min	Тур	Max	Uiiit
Invest Valtage	V <sub>I(off)</sub>	Vcc= -5V, Io= -100uA	-0.5			V
Input Voltage	V <sub>I(on)</sub>	Vo= -0.3V, Io= -10mA			-3	V
Output Voltage	Vo(on)	lo / l <sub>i</sub> = -10mA/-0.5mA			-0.3	V
Input Current	lı	V <sub>I</sub> = -5V			-0.88	mA
Output Current	IO(off)	$V_{CC} = -50V, V_{I} = 0$			-0.5	uA
DC Current Gain	Gı	$V_{O} = -5V, I_{O} = -5mA$	30			
Input Resistance	R <sub>1</sub>		7	10	13	ΚΩ
Resistance Ratio	R <sub>2</sub> /R <sub>1</sub>		0.8	1	1.2	
Transition Frequency	fτ	Vo = -10V, lo = -5mA f=100MHz		250		MHz



# **PACKAGE MECHANICAL DATA**

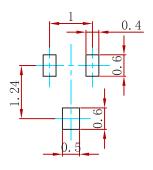






Cumbal	Dimensions In Millimeters		Dimensions In Inches	
Symbol	Min.	Max.	Min.	Max.
Α	0.700	0.900	0.028	0.035
A1	0.000	0.100	0.000	0.004
A2	0.700	0.800	0.028	0.031
b1	0.150	0.250	0.006	0.010
b2	0.250	0.350	0.010	0.014
С	0.100	0.200	0.004	0.008
D	1.500	1.700	0.059	0.067
Е	0.700	0.900	0.028	0.035
E1	1.450	1.750	0.057	0.069
е	0.500	TYP.	0.020	TYP.
e1	0.900	1.100	0.035	0.043
L	0.400 REF.		0.016	REF.
L1	0.260	0.460	0.010	0.018
θ	0°	8°	0°	8°

# **Suggested Pad Layout**



#### Note:

- 1.Controlling dimension:in millimeters.
- 2.General tolerance:±0.05mm.
- 3. The pad layout is for reference purposes only.

### **REEL SPECIFICATION**

P/N	PKG	QTY
DTA114EE(MS)	SOT-523	3000



#### **Attention**

- Any and all MSKSEMI Semiconductor products described or contained herein do not have specifications that can handle applications that require extremely high levels of reliability, such as life-support systems, aircraft's control systems, or other applications whose failure can be reasonably expected to result in serious physical and/or material damage. Consult with your MSKSEMI Semiconductor representative nearest you before using any MSKSEMI Semiconductor products described or contained herein in such applications.
- MSKSEMI Semiconductor assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all MSKSEMI Semiconductor products described or contained herein.
- Specifications of any and all MSKSEMI Semiconductor products described or contained herein stipulate the performance, characteristics, and functions of the described products in the independent state, and are not guarantees of the performance, characteristics, and functions of the described products as mounted in the customer's products or equipment. To verify symptoms and states that cannot be evaluated in an independent device, the customer should always evaluate and test devices mounted in the customer'sproducts or equipment.
- MSKSEMI Semiconductor. strives to supply high-quality high-reliability products. However, any and all semiconductor products fail with someprobability. It is possiblethat these probabilistic failures could give rise to accidents or events that could endanger human lives, that could give rise to smoke or fire, or that could cause damage to other property. When designing equipment, adopt safety measures so that these kinds of accidents or events cannot occur. Such measures include but are not limited to protective circuits anderror prevention circuitsfor safedesign, redundant design, and structural design.
- In the event that any or all MSKSEMI Semiconductor products (including technical data, services) described or contained herein are controlled under any of applicable local export control laws and regulations, such products must not be exported without obtaining the export license from theauthorities concerned in accordance with the above law.
- No part of this publication may be reproduced or transmitted in any form or by any means, electronic or mechanical, including photocopying and recording, or any information storage or retrieval system, or otherwise, without the prior written permission of MSKSEMI Semiconductor.
- Information (including circuit diagrams and circuit parameters) herein is for example only; it is not guaranteed for volume production. MSKSEMI Semiconductor believes information herein is accurate and reliable, but no guarantees are made or implied regarding its use or any infringements of intellectual property rights or other rights of third parties.
- Any and all information described or contained herein are subject to change without notice due to product/technology improvement, etc. Whendesigning equipment, referto the "Delivery Specification" for the MSKSEMI Semiconductor productthat you intend to use.